

Notice of References Cited	Application/Control No. 10/646,542		Applicant(s)/Patent Under Reexamination NIIHARA ET AL.	
	Examiner Cam N. Nguyen		Art Unit 1754	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,156,685	12-2000	Marella et al.	501/95.1
*	C	US-2003/0135971	07-2003	Liberman et al.	29/419.1
*	D	US-5,801,114	09-1998	Durand et al.	502/302
*	E	US-5,723,403	03-1998	Durand et al.	502/304
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*	I	US-3,992,498	11-1976	Morton et al.	264/639
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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